Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10722418	BOHN ET AL.
Examiner	Art Unit
Nauven Jennifer T	2629

SEARCHED							
Class	Subclass	Date	Examiner				
345	156,157,163-168,179	3/30/07	JN				

SEARCH NOTES						
Search Notes	Date	Examiner				
east (US-PAT, PG-PUB), IEEE, JPO	3/30/07	JN				

INTERFERENCE SEARCH						
Class		Subclass	Date	Examiner		
178	18.01-18.09		3/30/07	JN		

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